		Notice of References Cited			n/Control No.	Applicant(s)/Patent Under Reexamination YOSHINO ET AL.		
•				Examiner		Art Unit	Page 1 of 1	
				Phil Wiest				
		Document Number	Date	U.S. PATENT DOCI	UMENTS			
*		Country Code-Number-Kind Code	MM-YYYY		Name		Classification	
*	Α	US-6,150,582	11-2000	Wada et al.			604/372	
*	В	US-5,601,542	02-1997	Melius et al.			604/368	
	С	US-						
	D	US-						
	E	US-					·	
	F	US-						
	G	US-						
	Н	US-						
	1	US-						
	J	US-						
	К	US-						
	L	US-						
	м_	US-						
		I Daywood Marshan	Date	FOREIGN PATENT D	OCUMENTS			
*		Document Number Country Code-Number-Kind Code	MM-YYYY	Country	N	ame	Classification	
	N							
	0							
	Р						·	
	1		,			1		
	Q				<u> </u>			
	Q R_							
-	 							
	R							
	R S			NON-PATENT DOG				
*	R S	Inclu	ide as applicabl	NON-PATENT DOC e: Author, Title Date, Po		lume, Pertinent Pages)		
*	R S T	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	R S	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	R S T	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	RST	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	R S T	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	RST	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	RST	Inclu	ide as applicabl			lume, Pertinent Pages)		
*	RST	Inclu	ide as applicabl			lume, Pertinent Pages)		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.